

Two Dimensional Electron Gases at Oxide Interfaces

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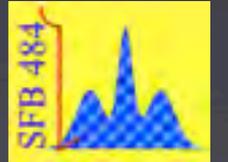
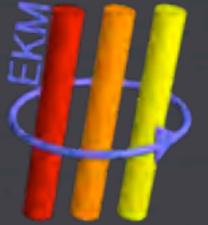
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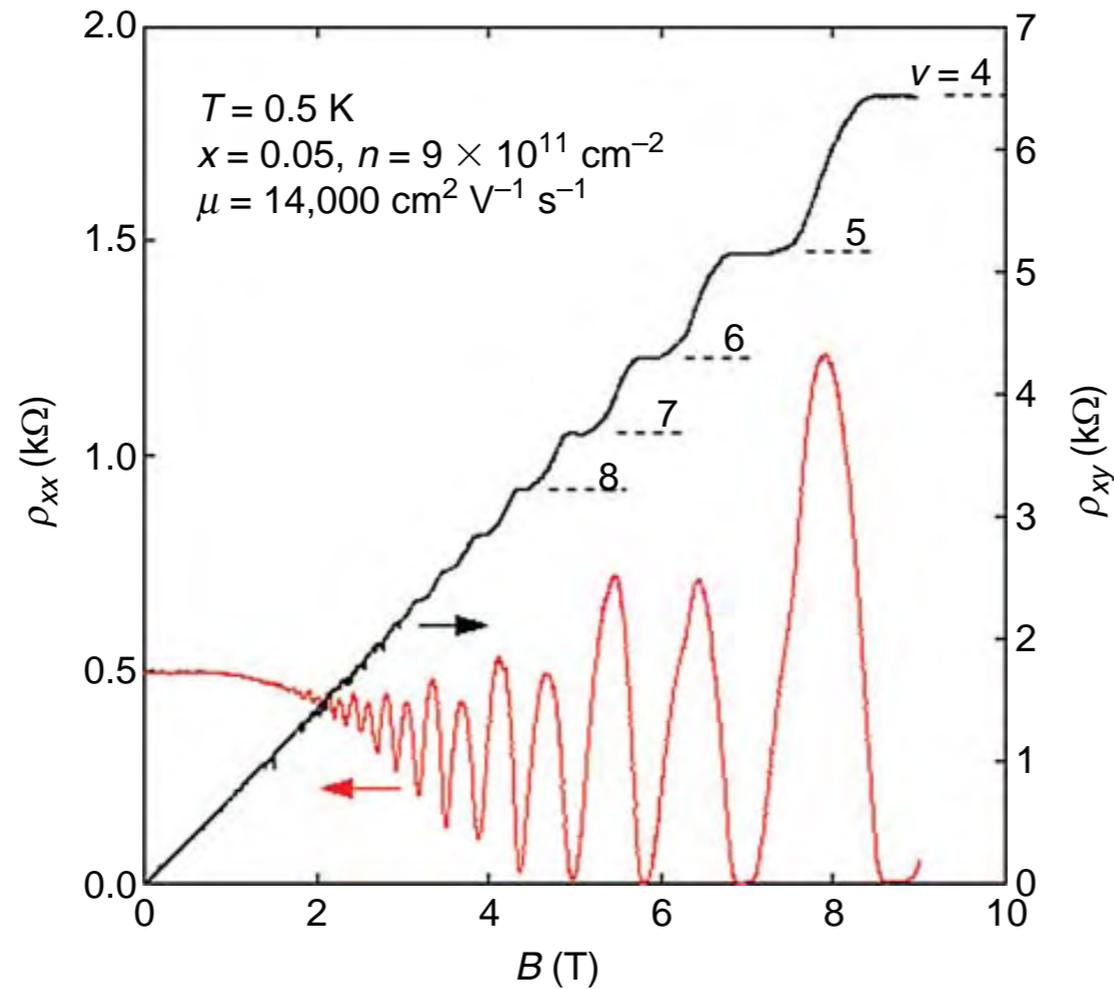
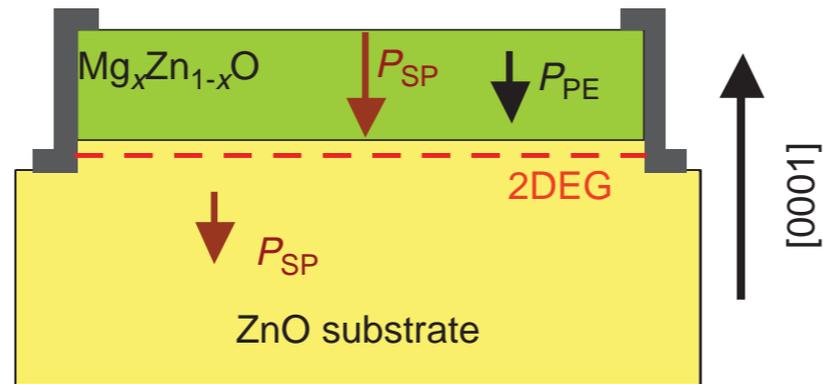
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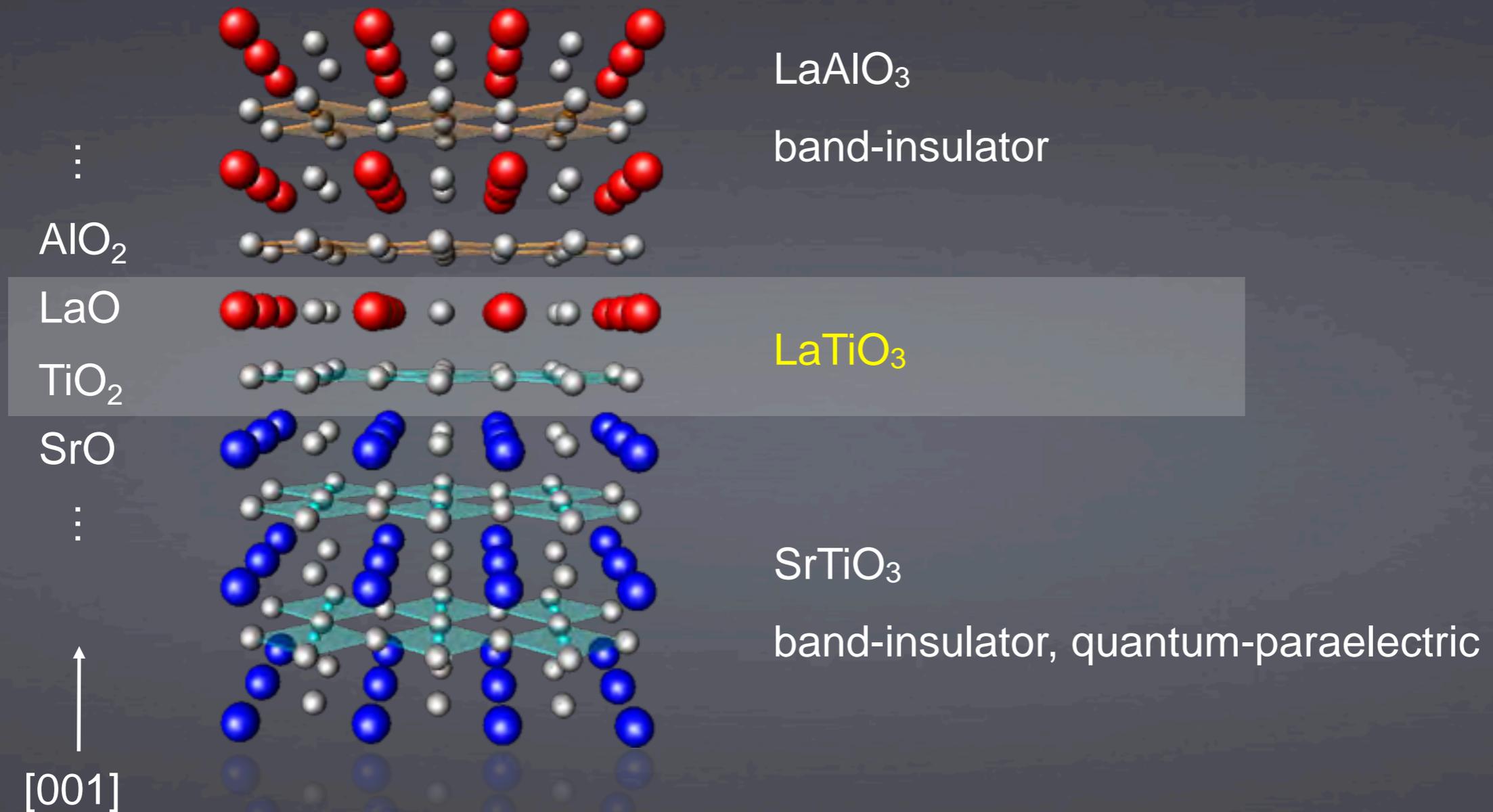


2-DEGs Can Be Realized in Oxides



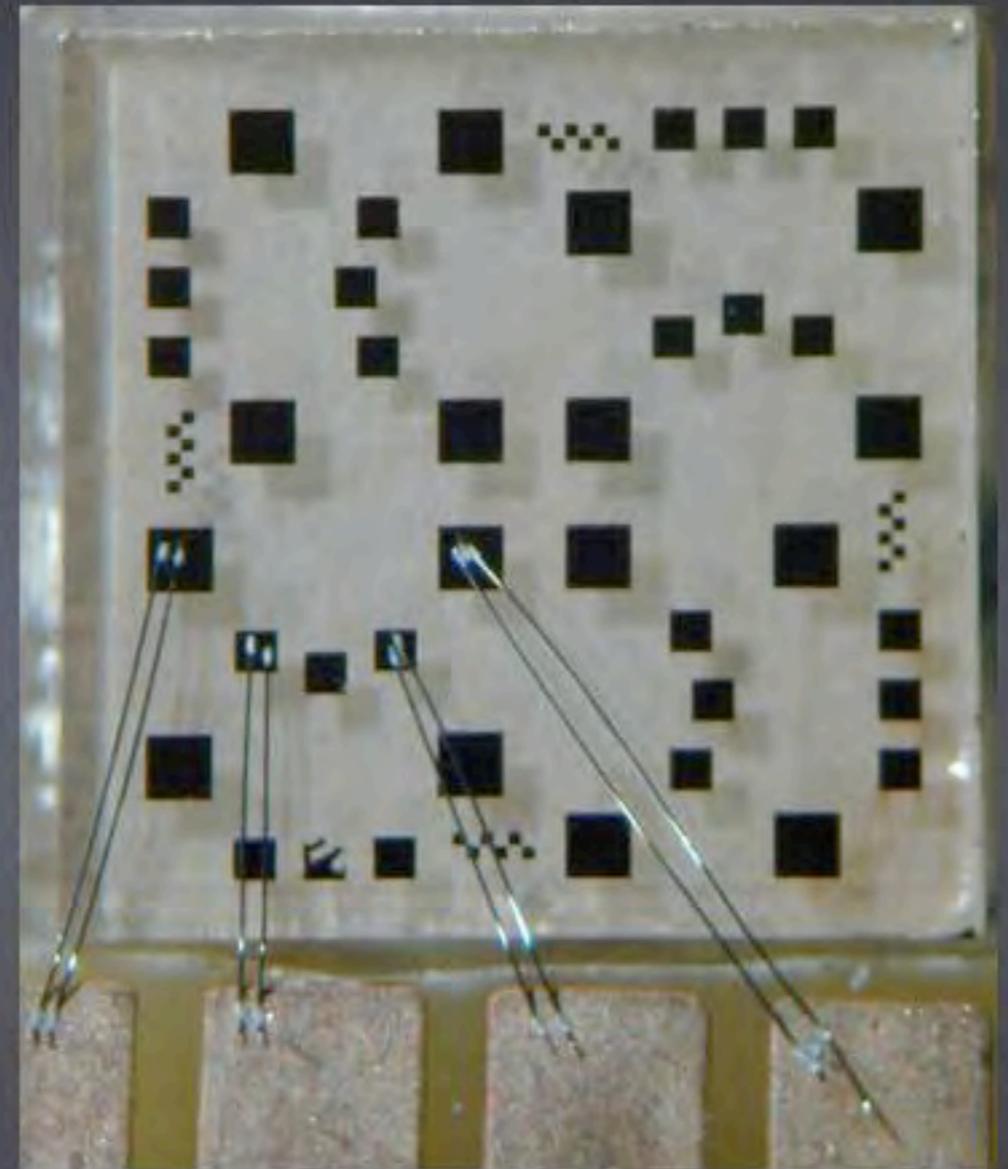
A. Tsukazaki *et al.*, Science (2007)

The *n*-type LaAlO₃ / SrTiO₃ Interface



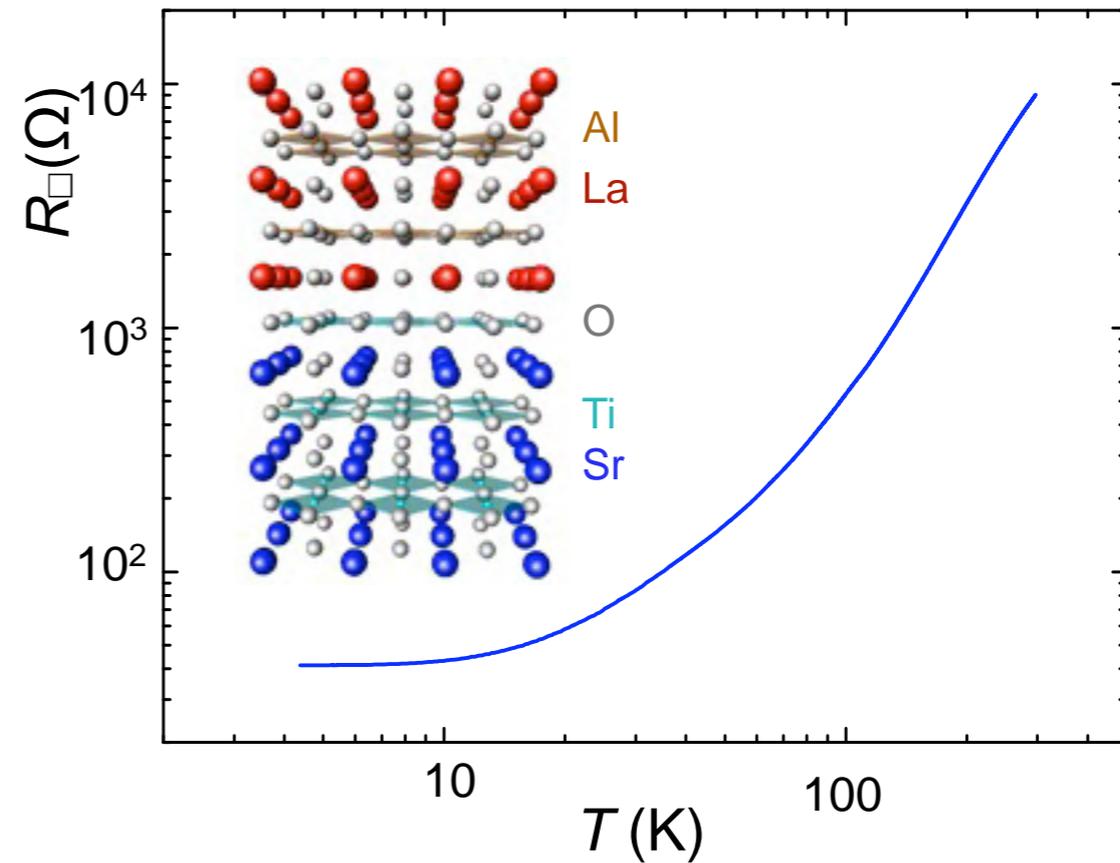
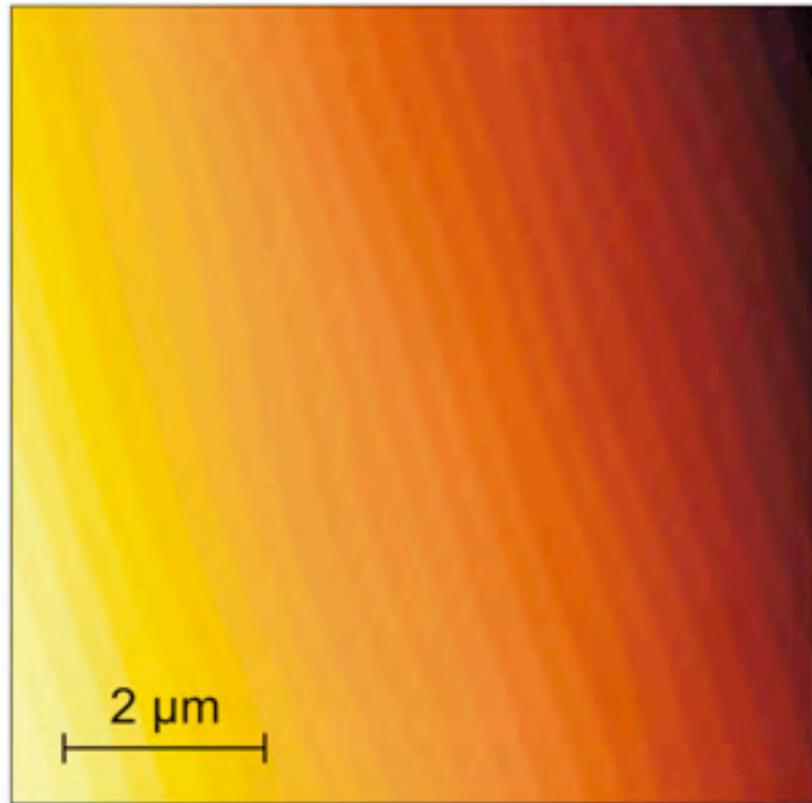
Sample Configuration

Contacts via ion-etching and Au-sputtering



5 mm

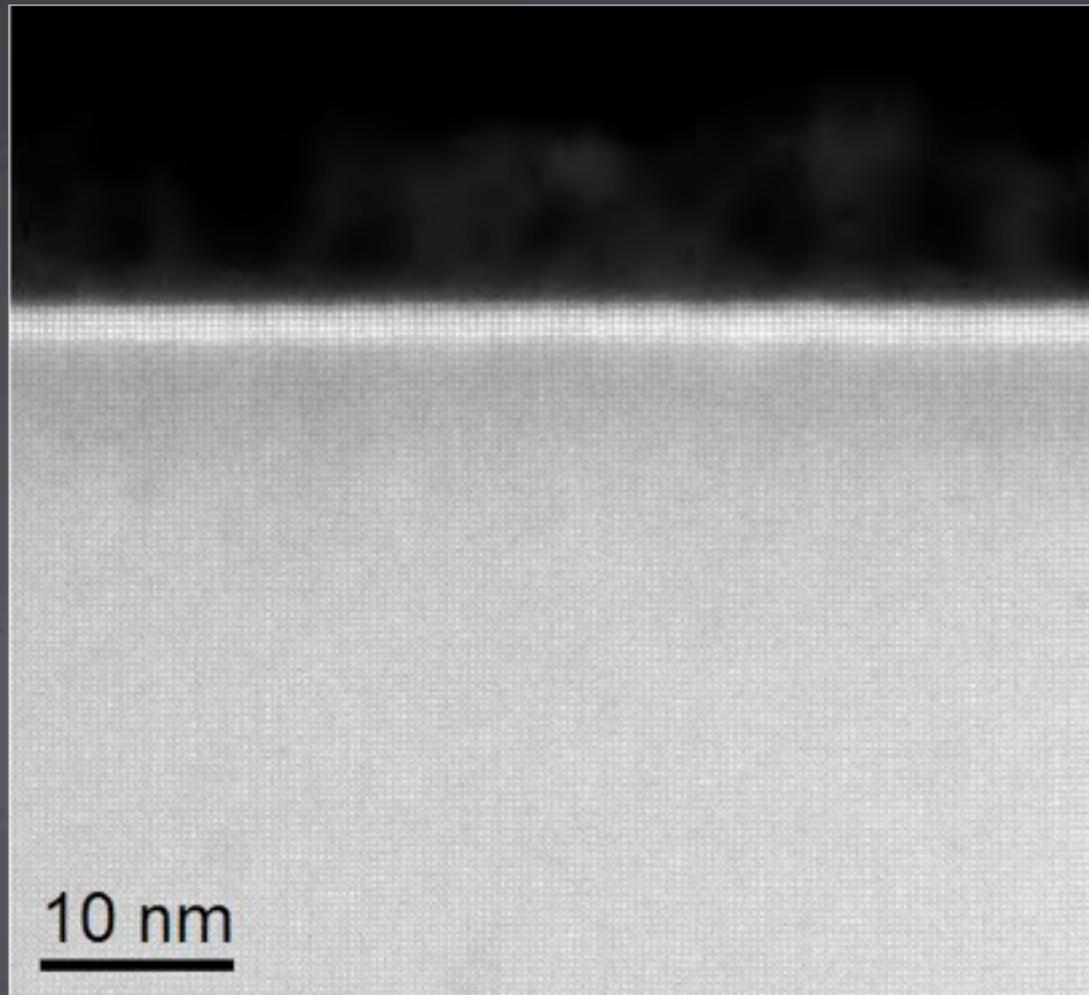
8 unit cells LaAlO_3 on SrTiO_3



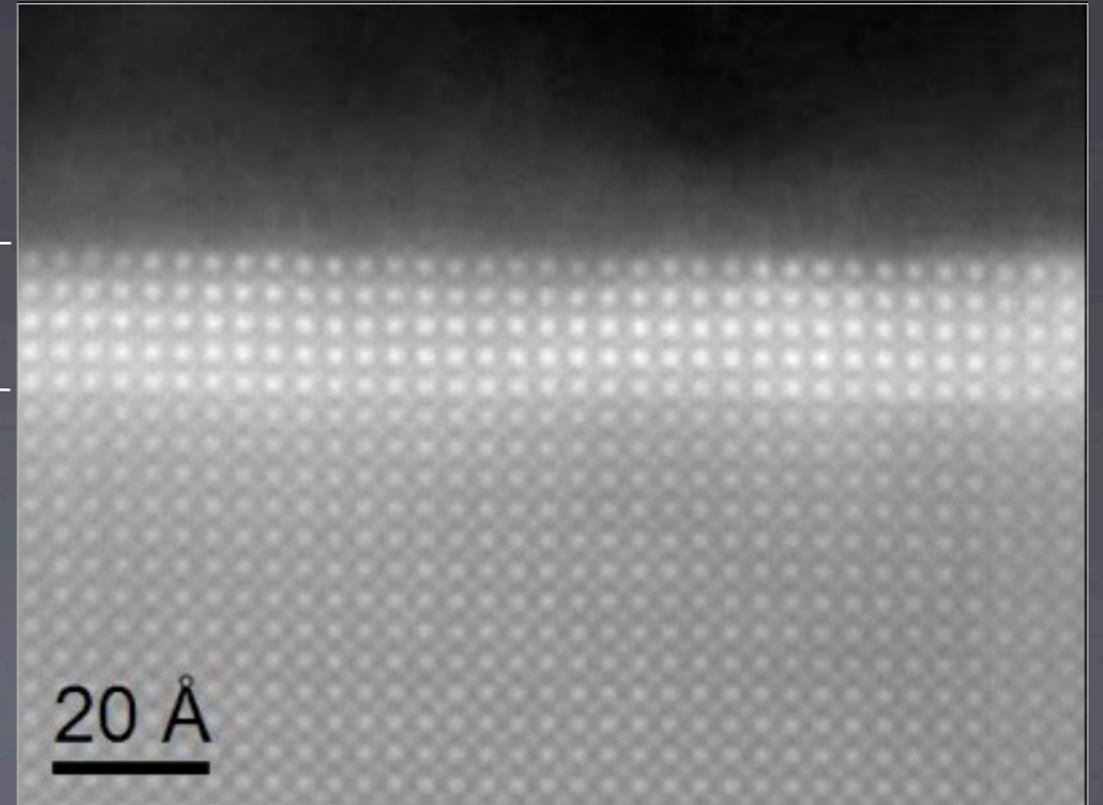
	$\sigma_s (\Omega/\square)^{-1}$	$n_s (\text{cm}^{-2})$	$\mu (\text{cm}^2/\text{Vs})$
300 K	5×10^{-5}	$2-4 \times 10^{13}$	7
4.2 K	5×10^{-3}	$2-4 \times 10^{13}$	700

STEM: Cross Section

HAADF



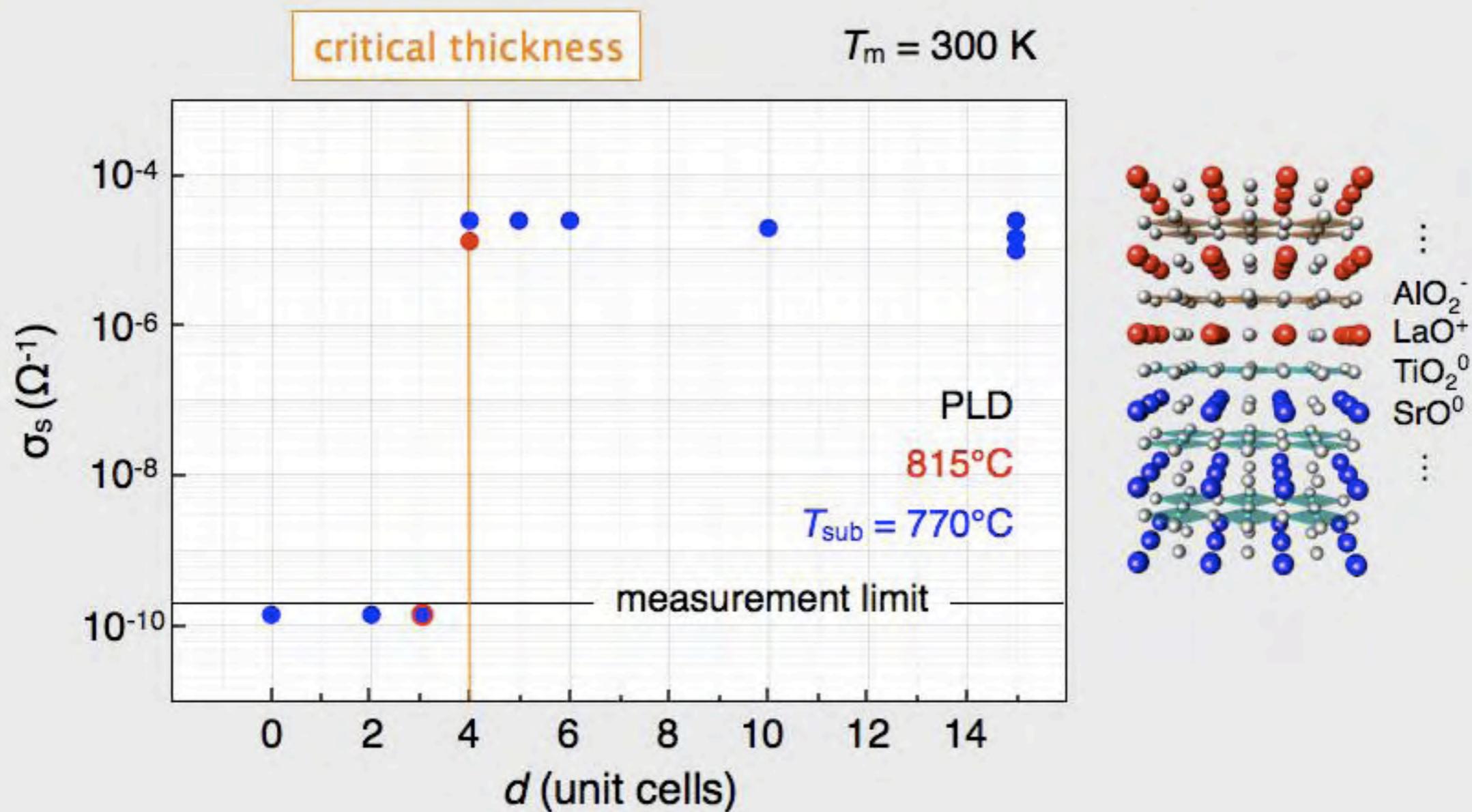
LAADF



5 uc
LaAlO₃

[001]
↑
SrTiO₃
Substrate

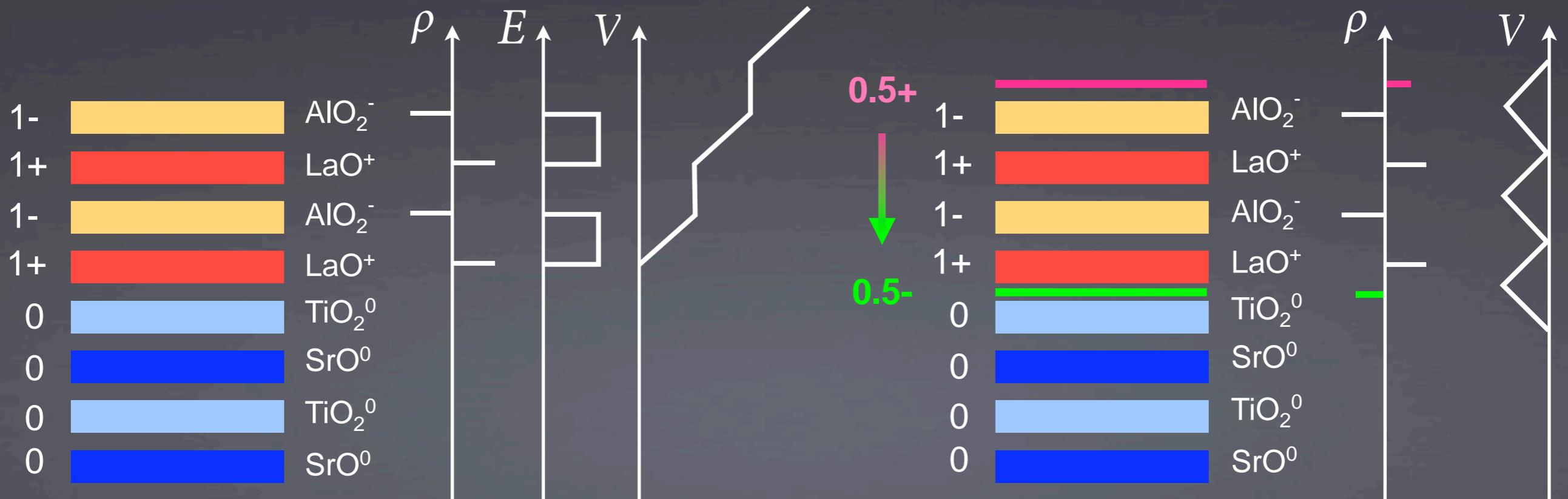
Interface Conductivity vs Number of LaAlO₃ Unit Cells



reproduced by Chalmers, Geneva, Naples, Stanford, Tokyo, Twente

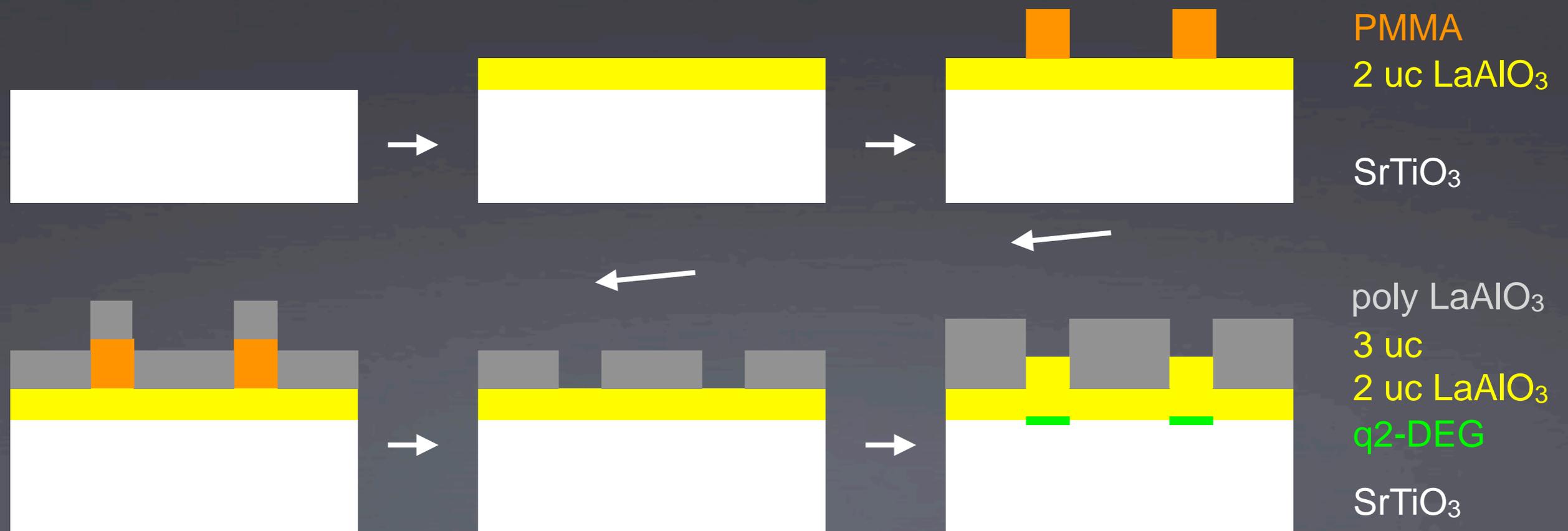
S. Thiel *et al.*, Science **313**, 1942 (2006)

The Polar Catastrophe is another Possible Source of Charge Carriers



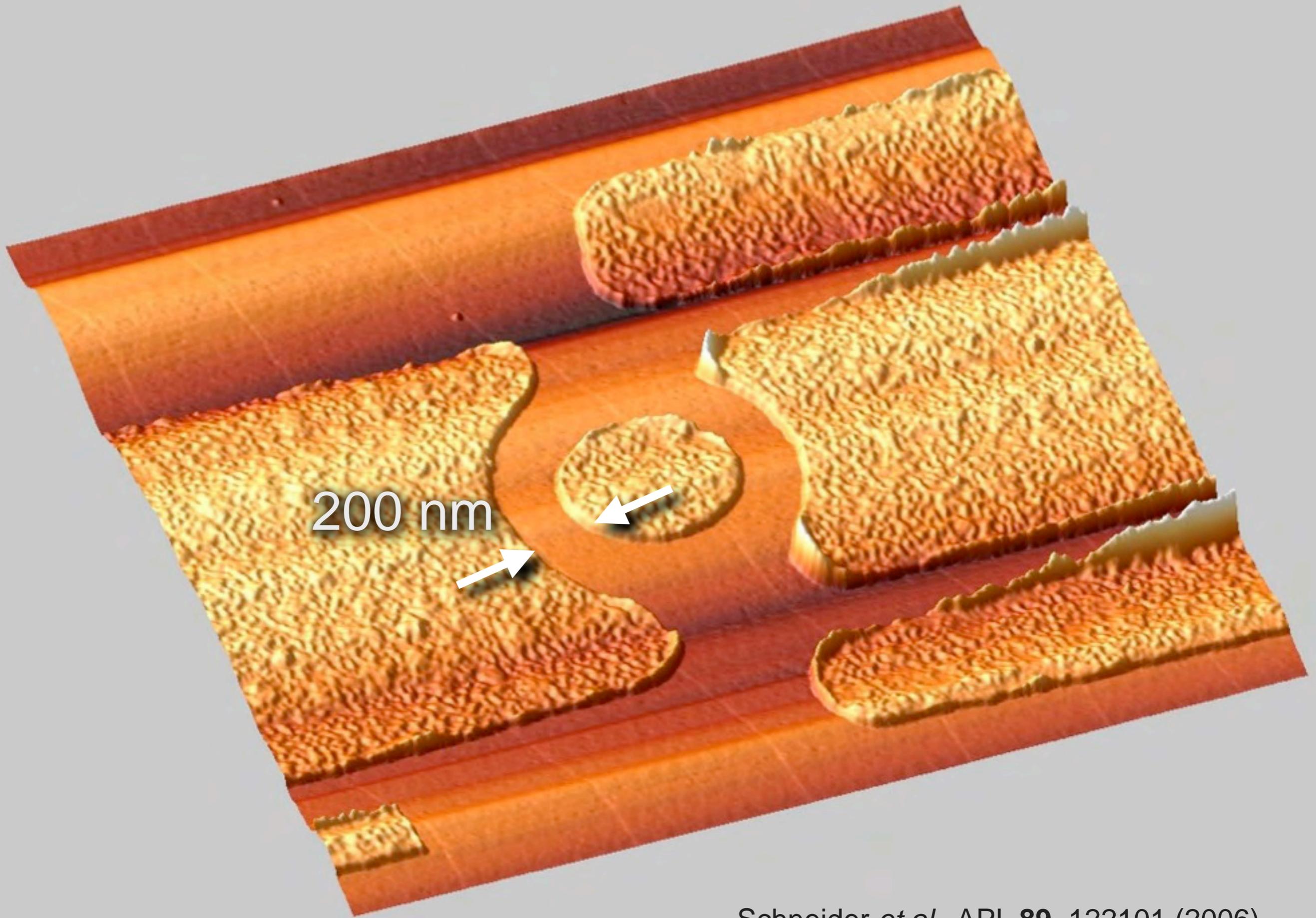
N. Nakagawa *et al.*, Nature Materials (2006)

Patterning the Electron Gas



- interface is not exposed to environment
- surface remains unexposed
- compatible with standard lithography techniques

Schneider *et al.*, APL **89**, 122101 (2006)



200 nm

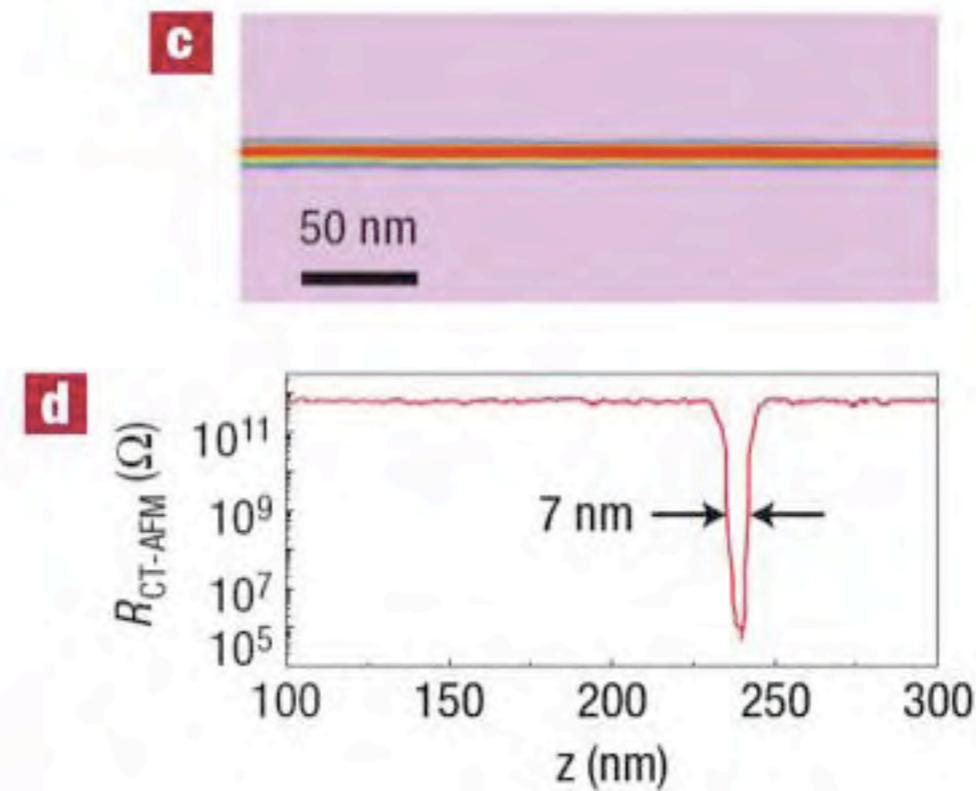
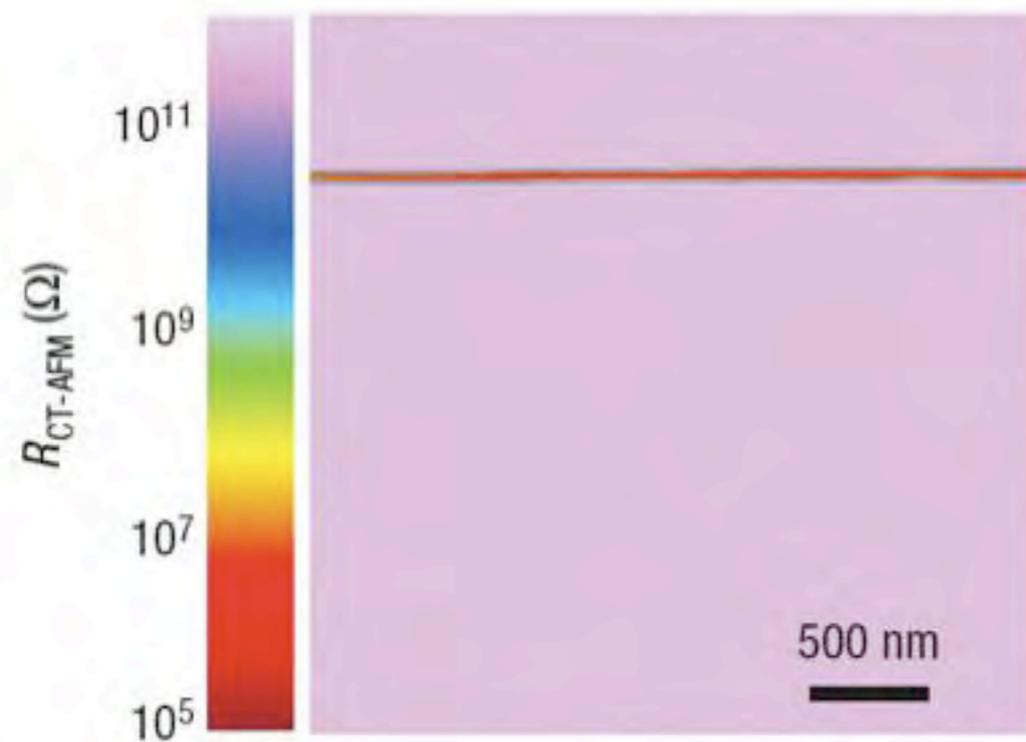
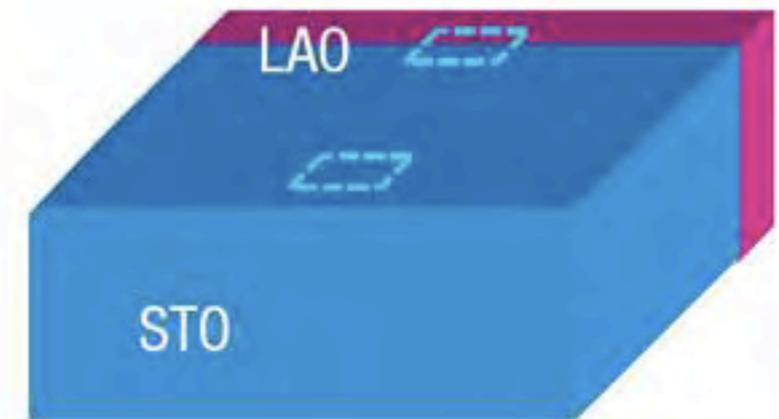
Mapping the spatial distribution of charge carriers in $\text{LaAlO}_3/\text{SrTiO}_3$ heterostructures

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Profiling the interface electron gas of $\text{LaAlO}_3/\text{SrTiO}_3$ heterostructures by hard X-ray photoelectron spectroscopy

M. Sing,¹ G. Berner,¹ K. Goß,¹ A. Müller,¹ A. Ruff,¹ A. Wetscherek,¹ S. Thiel,² J. Mannhart,²
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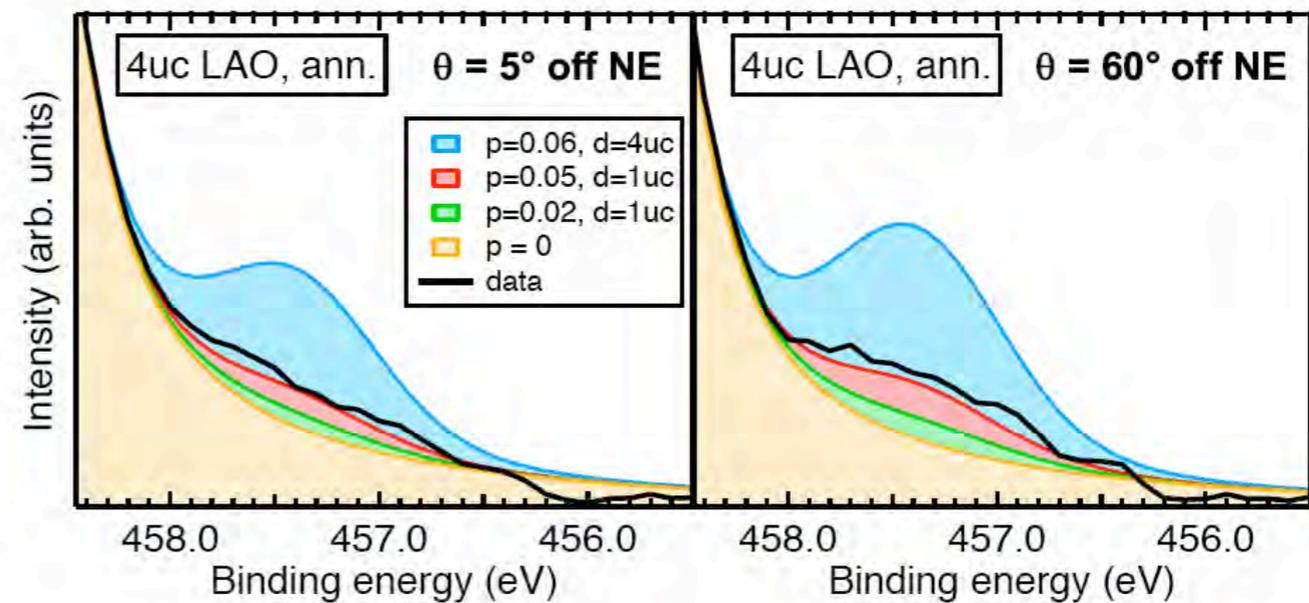
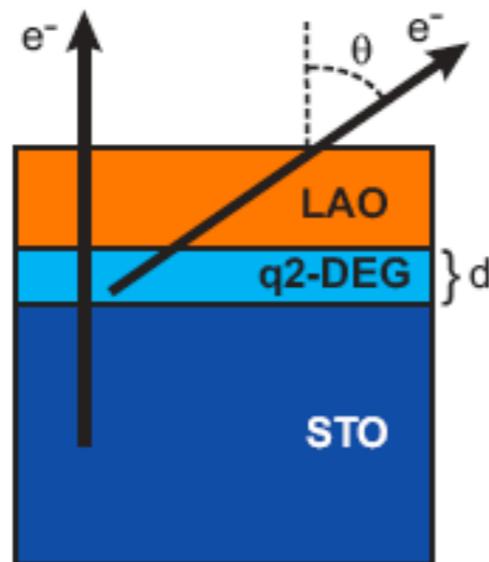
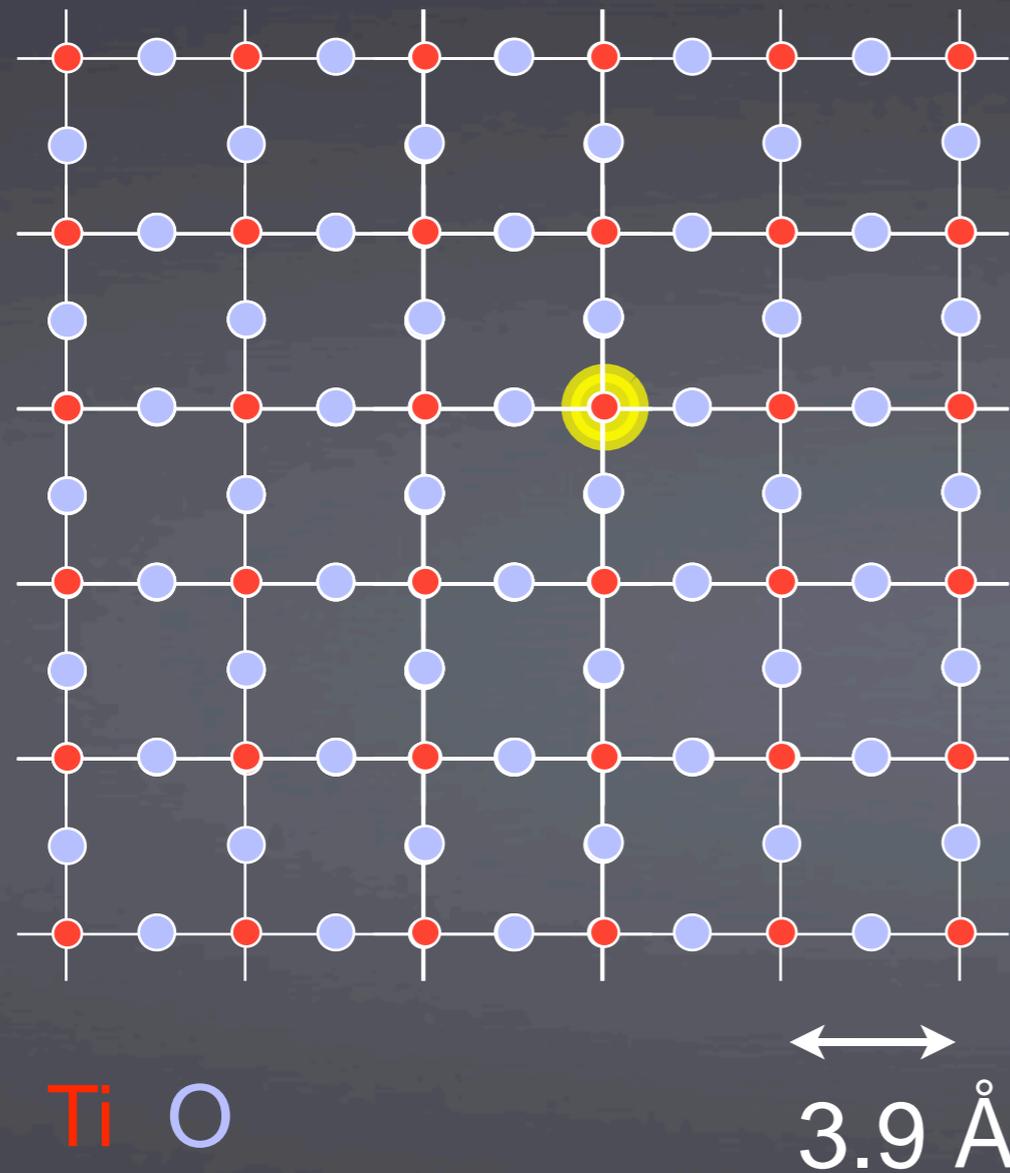


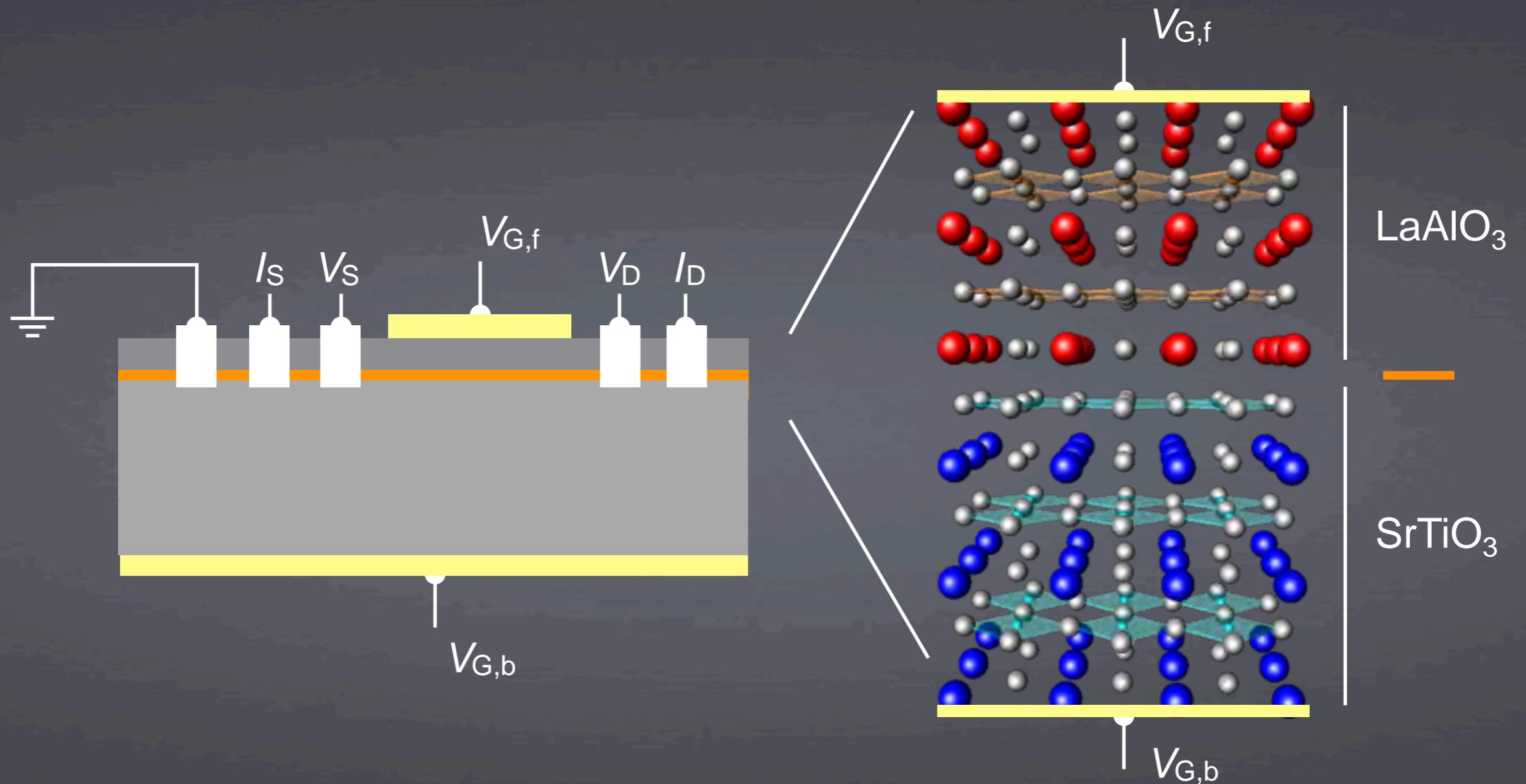
FIG. 4: (Color online) Comparison between experimental data and simulated spectra of the Ti^{3+} spectral weight for the annealed 4 uc sample.

Low Carrier Density at the Interfaces $\sim 2-4 \times 10^{13}/\text{cm}^2$

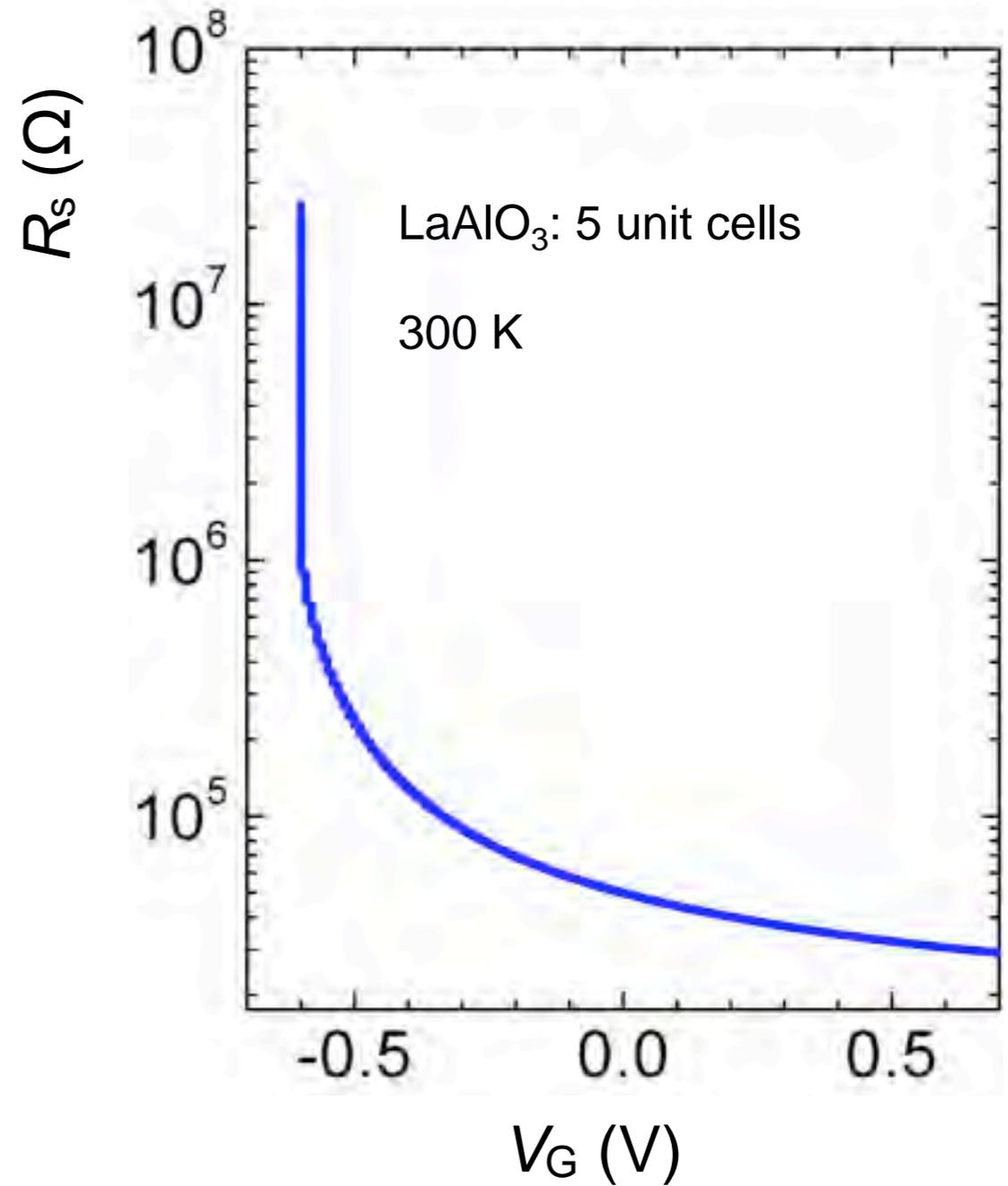
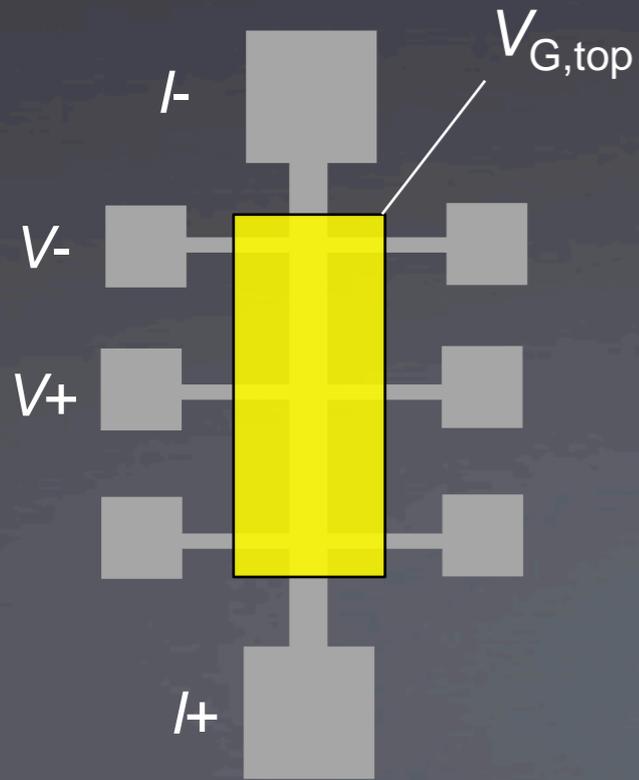


TiO_2 -plane

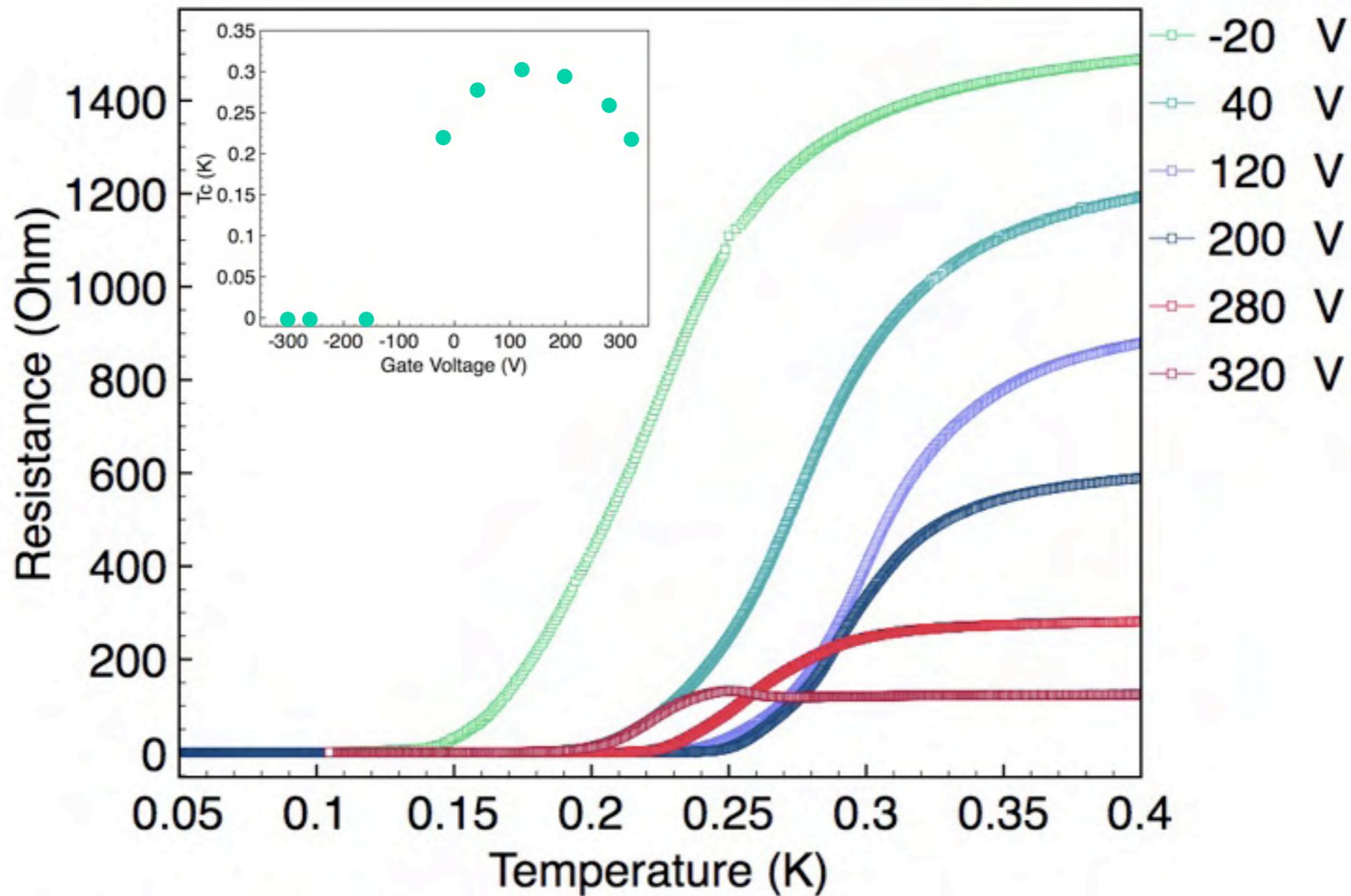
Gate-Field Induced Phase Transition to 2-DEG?



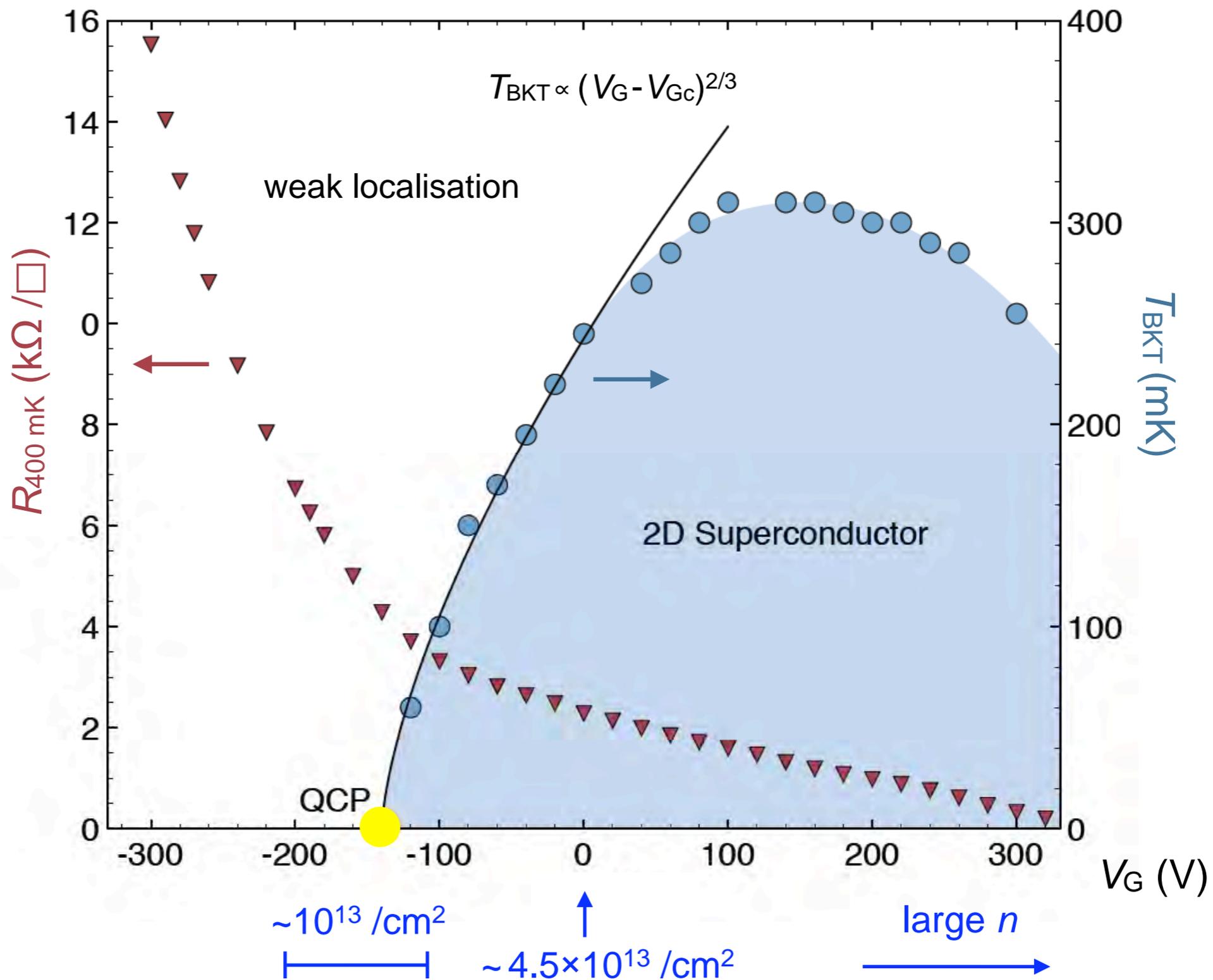
Field Effect Experiments - Top Gate



Field Effect Tuning of the Interface Properties

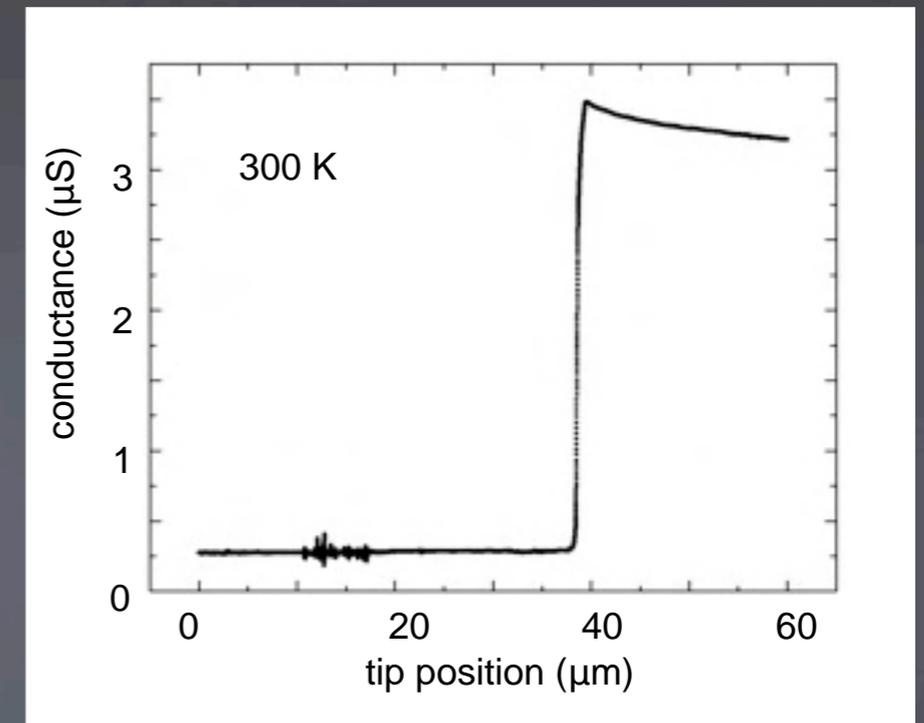
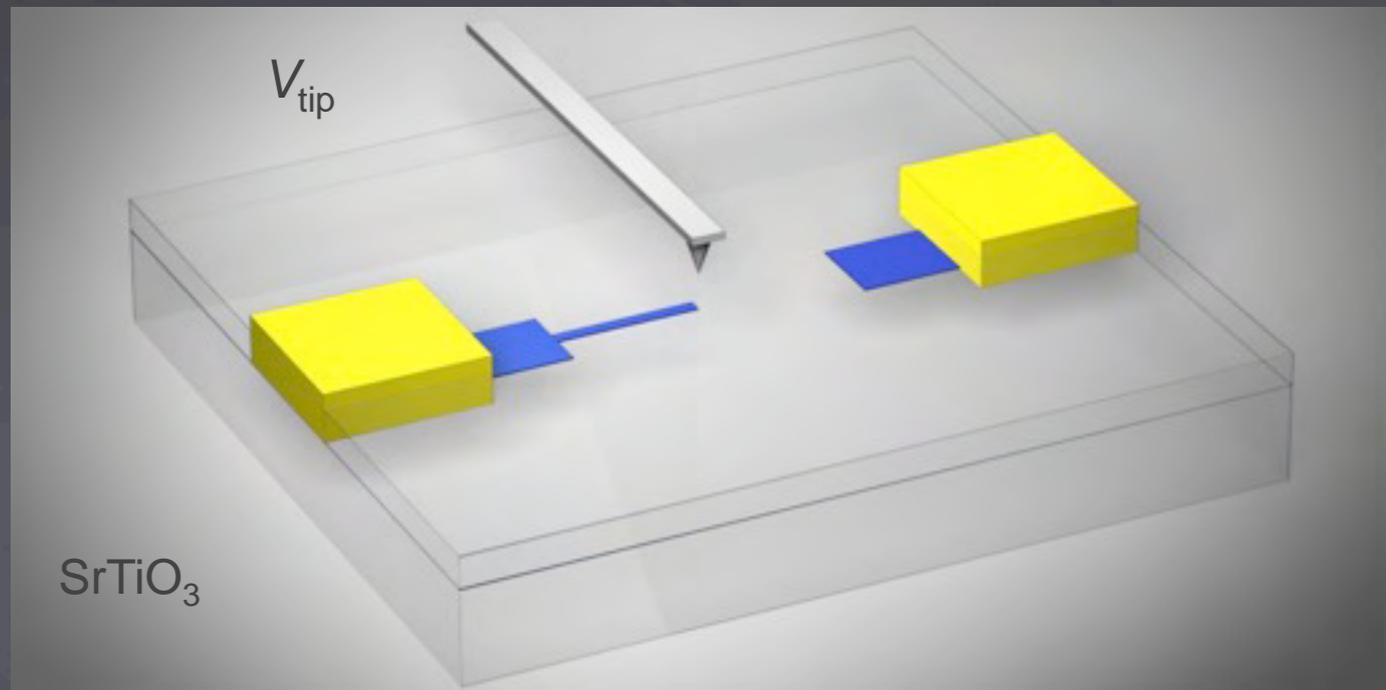


Measured Phase Diagram of the LaAlO₃/SrTiO₃ Interface



Electric Field Lithography

- induce insulator-metal transition locally

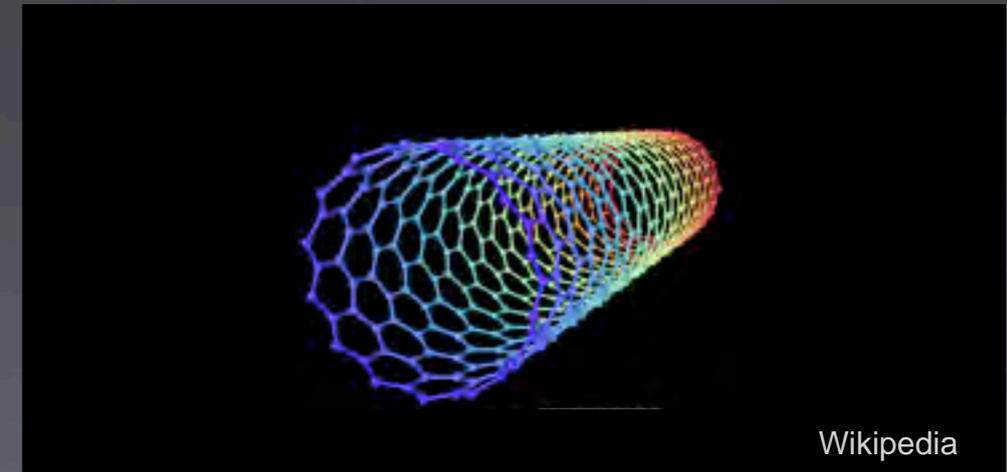
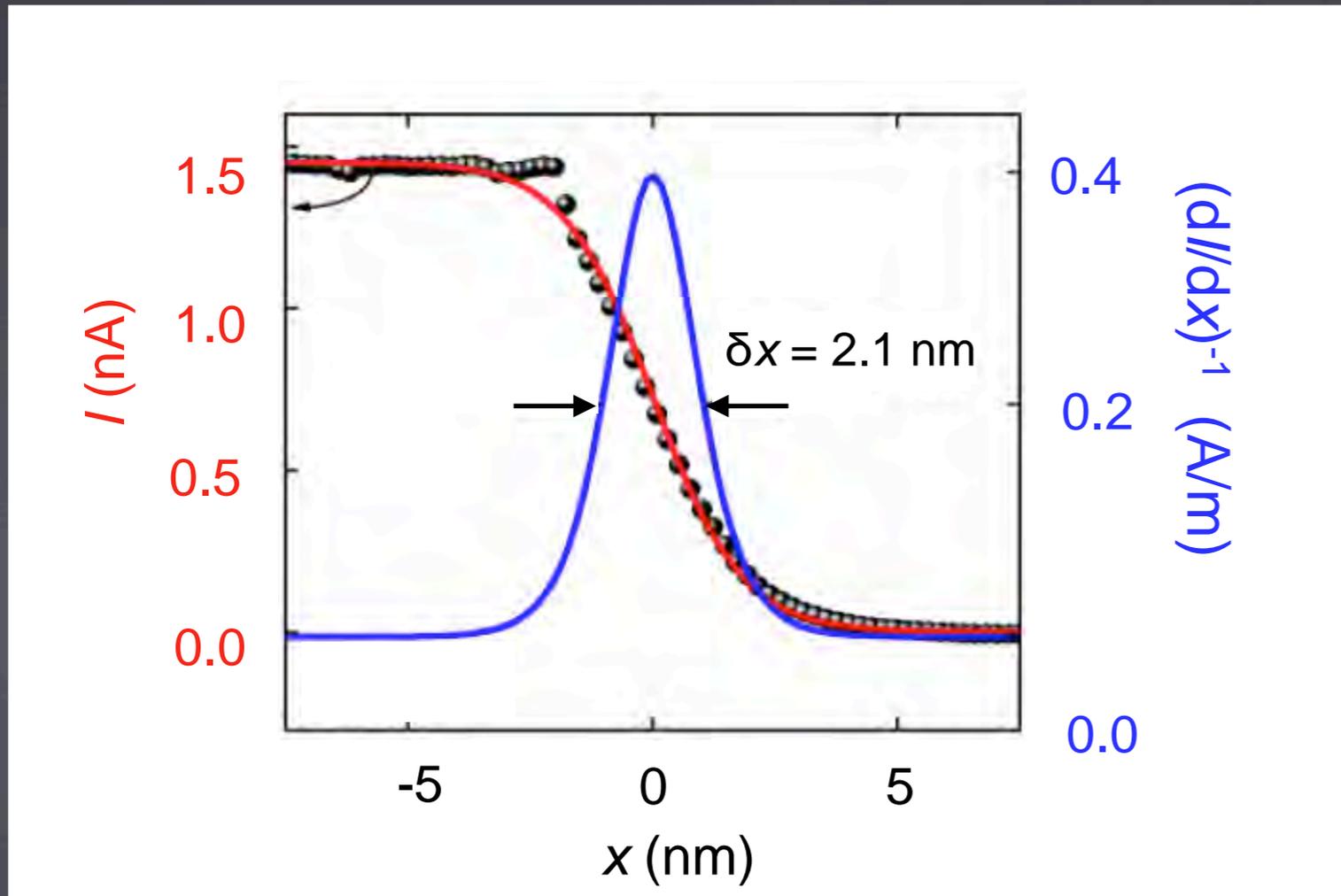


Nanowires

- can be written and erased repeatedly
- are stable at 300 K for > 24 h (but not always)

Electric Field Lithography

- induce insulator-metal transition locally

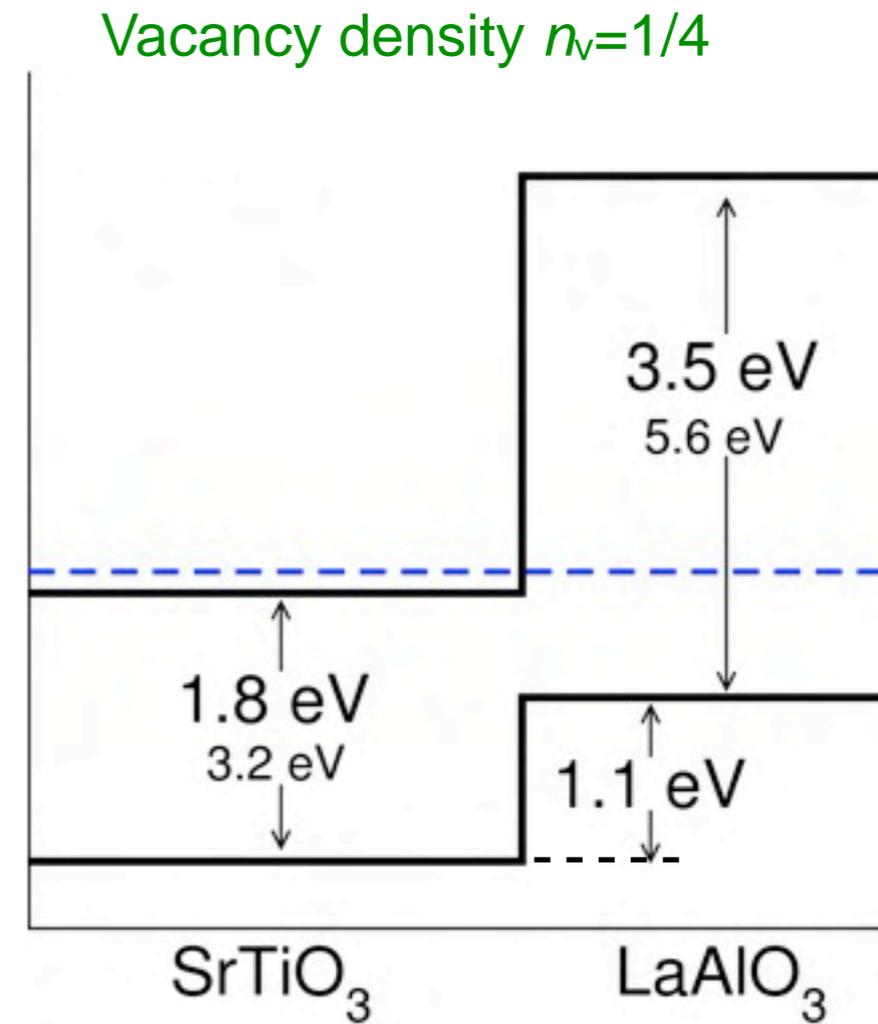
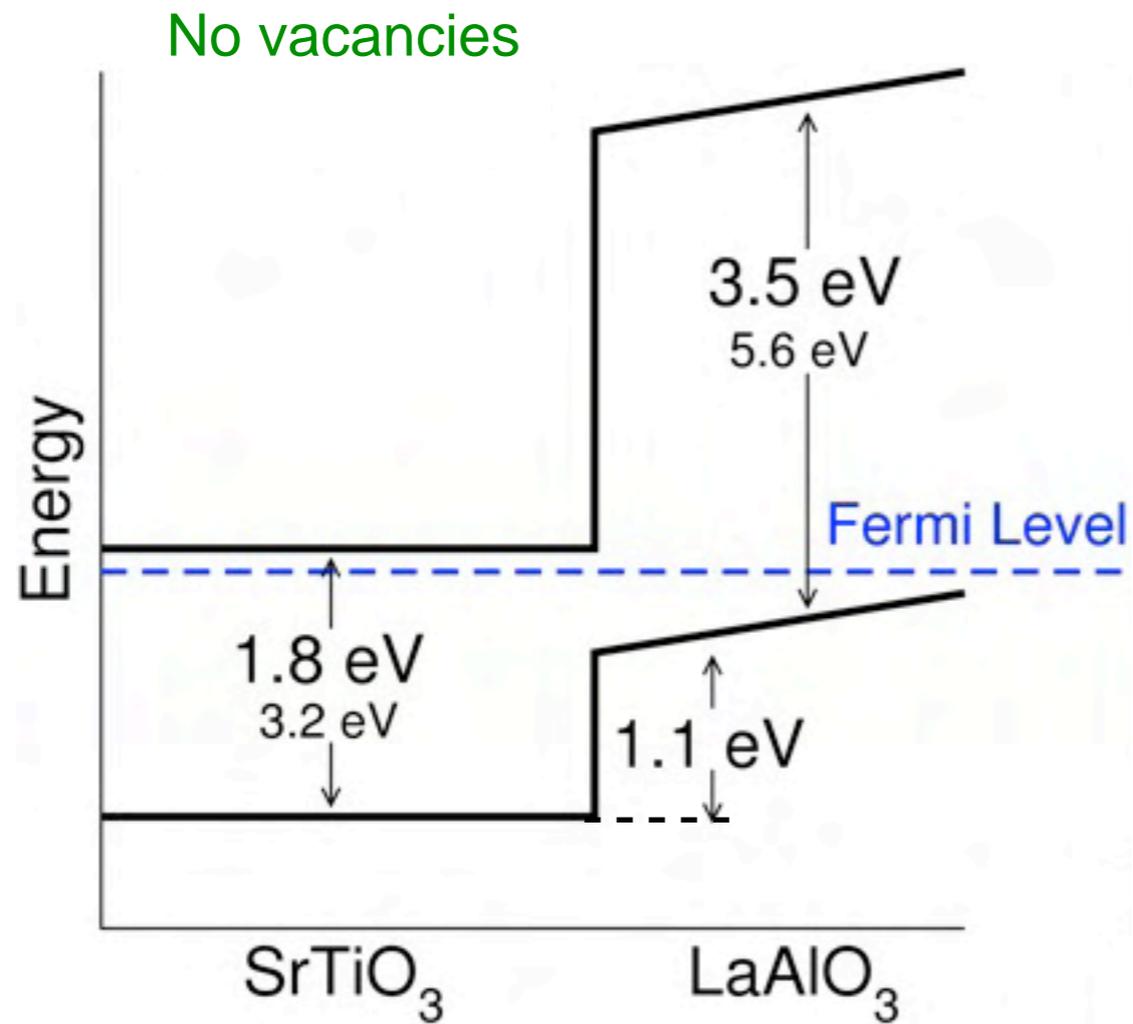


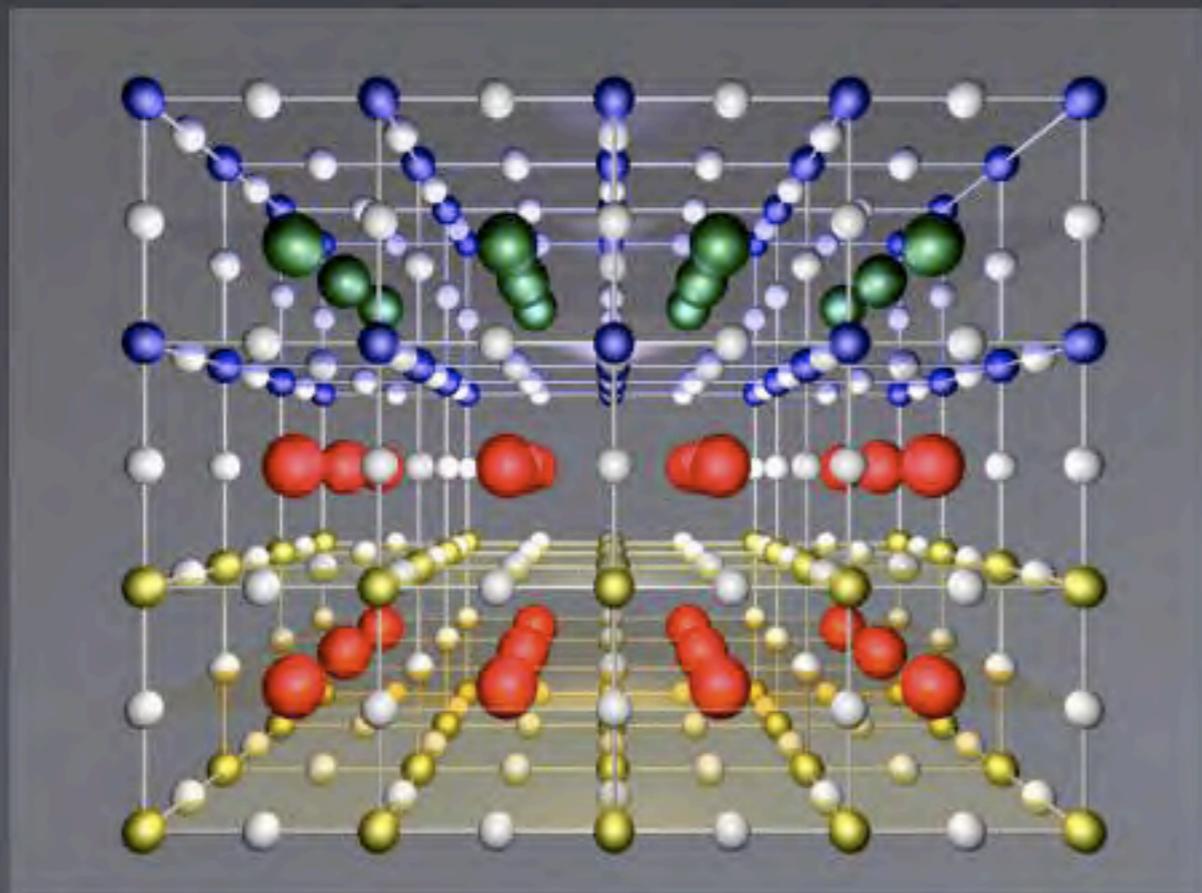
written wires with nanotube diameter

Nanowires

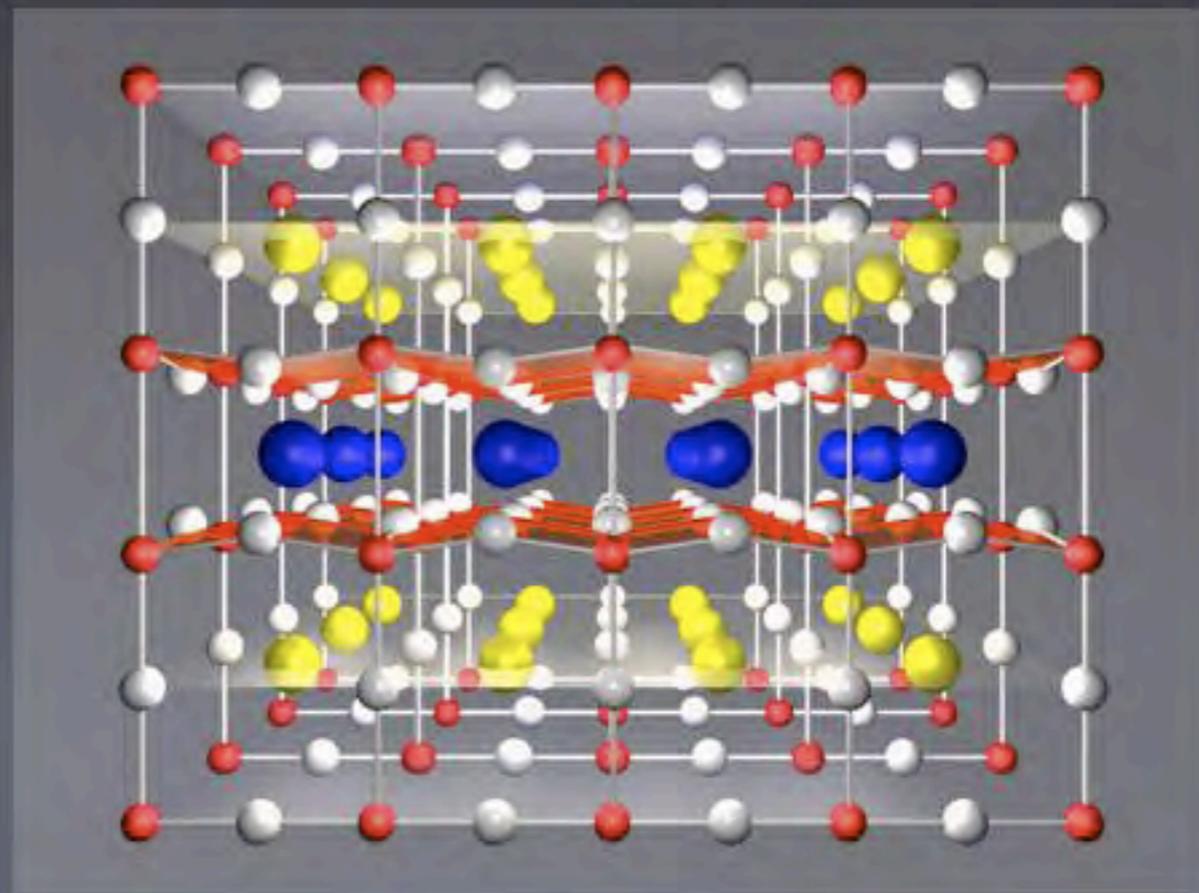
- can be written and erased repeatedly
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Possible Writing Mechanism

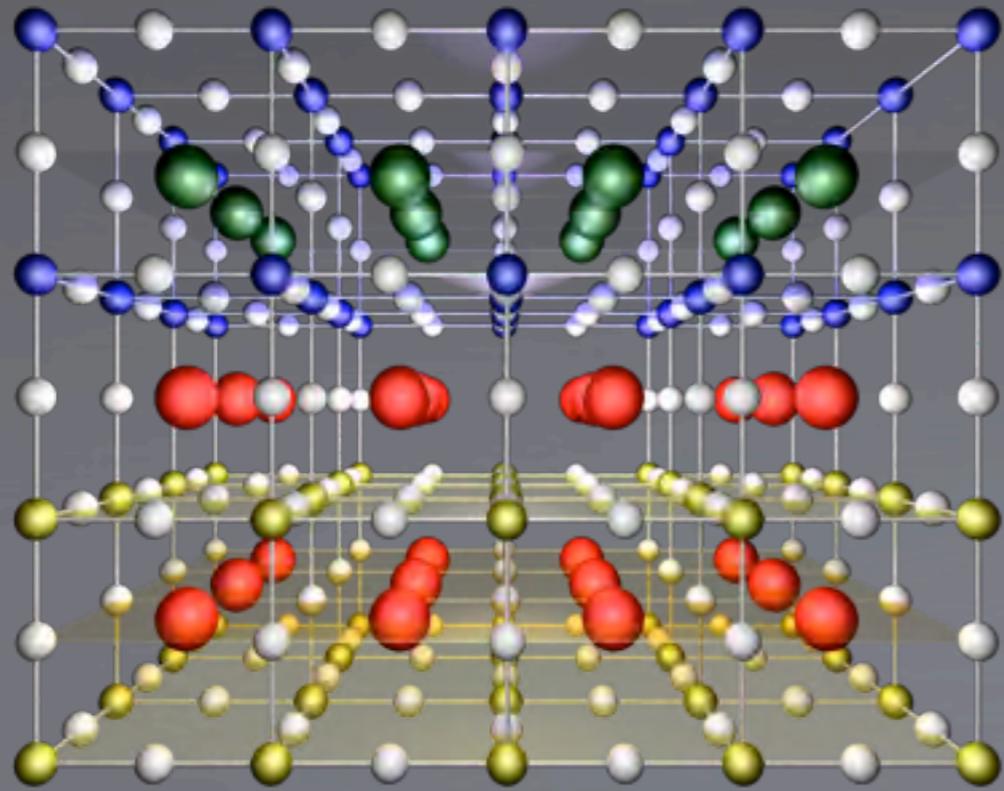




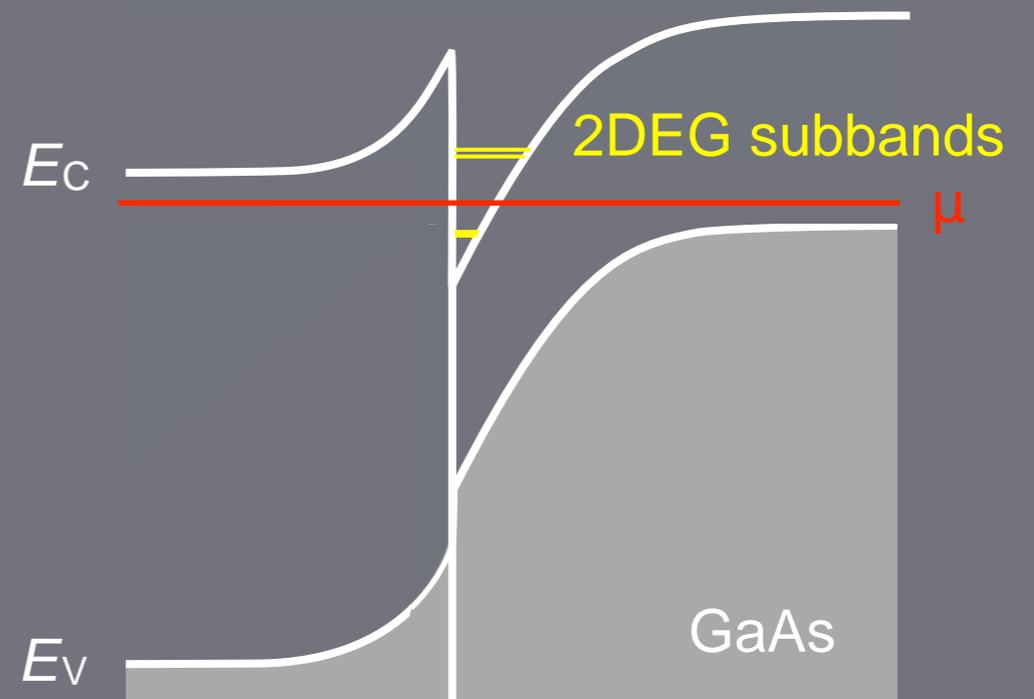
$\text{LaAlO}_3/\text{SrTiO}_3$



$\text{YBa}_2\text{Cu}_3\text{O}_7$



LaAlO₃/SrTiO₃



(AlGa)As/GaAs Heterostructure